Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/047,100	MILLER ET AL.
Examiner	Art Unit
Frin M File	2634

SEARCHED					
Class	Subclass	Date	Examiner		
375	347	7/26/2005	EMF		
375	346	3/30/2005	EMF		
455	132	3/30/2005	EMF		
455	296	3/30/2005	EMF		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
375	347	7/26/2005	EMF	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	7/26/2005	EMF		
PALM INVENTORSHIP	3/30/2005	EMF		
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